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|-----------------------------------|---------------------------------------|--|--|-------------|
| Notice of References Cited | Application/Control No. 10/017,664 | | Applicant(s)/Patent Under Reexamination CHEVALLIER, CHRISTOPHE | |
| | Examiner Viet Q. Nguyen | | Art Unit 2818 | Page 1 of 2 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|------------------------|----------------|
| | A | US-2002/0085423 A | 07-2002 | Tedrow et al. | 365/185.21 |
| | B | US-5,894,437 | 04-1999 | Pellegrini, Gianfranco | 365/185.13 |
| * | C | US-6,628,563 | 09-2003 | Hsu et al. | 365/230.03 |
| * | D | US-2003/0090949 A | 05-2003 | Tedrow et al. | 365/200 |
| * | E | US-6,507,515 | 01-2003 | Taniguchi, Tsutomu | 365/185.17 |
| * | F | US-6,064,592 | 05-2000 | Nakagawa et al. | 365/185.05 |
| * | G | US-6,282,145 | 08-2001 | Tran et al. | 365/230.06 |
| * | H | US-5,748,545 | 05-1998 | Lee et al. | 365/201 |
| * | I | US-5,245,570 | 09-1993 | Fazio et al. | 365/185.13 |
| * | J | US-5,526,307 | 06-1996 | Yiu et al. | 365/185.01 |
| * | K | US-5,621,690 | 04-1997 | Jungroth et al. | 365/200 |
| * | L | US-5,805,501 | 09-1998 | Shiau et al. | 365/185.29 |
| * | M | US-6,262,914 | 07-2001 | Smayling et al. | 365/185.11 |

Viet Q. Nguyen
Primary Examiner

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|-------------|----------------|
| * | N | JP02002100187A | 04-2002 | Japan | Fujimoto | G11C 11/41 |
| * | O | JP411096750A | 04-1999 | Japan | Fujii | G11C 11/401 |
| * | P | JP408153856A | 06-1996 | Japan | Fujii | H01L 27/108 |
| * | Q | JP02001102464A | 04-1001 | Japan | Evans et al | H01L 21/8244 |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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|-----------------------------------|---------------------------------------|--|-------------|
| Notice of References Cited | Application/Control No. 10/017,664 | Applicant(s)/Patent Under Reexamination CHEVALLIER, CHRISTOPHE | |
| | Examiner Viet Q Nguyen | Art Unit 2818 | Page 2 of 2 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-----------------|----------------|
| * | A | US-6,515,906 | 02-2003 | Tedrow et al. | 365/185.21 |
| * | B | US-6,614,685 | 09-2003 | Wong, Sau Ching | 365/185.11 |
| * | C | US-6,704,222 | 03-2004 | Guterman et al. | 365/185.03 |
| | D | US- | | | |
| | E | US- | | | |
| | F | US- | | | |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

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FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
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| | N | | | | | |
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NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

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